SLOVENSKI STANDARD
oSIST prEN IEC 61131-9:2021

01-julij-2021

Programirljivi kontrolniki - 9. del: Enožični digitalni komunikacijski vmesnik za male senzorje in dajalnike

Programmable controllers - Part 9: Single-drop digital communication interface for small sensors and actuators (SDCI)

Speicherprogrammierbare Steuerungen - Teil 9: Schnittstelle für die Kommunikation mit kleinen Sensoren und Aktoren über eine Punkt-zu-Punkt-Verbindung

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Automates programmables - Partie 9: Interface de communication numérique point à point pour les petits capteurs et actionneurs (SDCI)

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Ta slovenski standard je istoveten z: **prEN IEC 61131-9:2021**

ICS:

25.040.40	Merjenje in krmiljenje industrijskih postopkov	Industrial process measurement and control
35.240.50	Uporabniške rešitve IT v industriji	IT applications in industry

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65B/1199/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER: **IEC 61131-9 ED2**	
DATE OF CIRCULATION: **2021-05-07**	CLOSING DATE FOR VOTING: **2021-07-30**
SUPERSEDES DOCUMENTS: **65B/1196/RR**	

IEC SC 65B : MEASUREMENT AND CONTROL DEVICES	
SECRETARIAT: United States of America	SECRETARY: Mr Angus Low
OF INTEREST TO THE FOLLOWING COMMITTEES: TC 65,SC 65C	PROPOSED HORIZONTAL STANDARD: ☐ Other TC/SCs are requested to indicate their interest, if any, in this CDV to the secretary.
FUNCTIONS CONCERNED: ☐ EMC ☐ ENVIRONMENT ☐ QUALITY ASSURANCE ☐ SAFETY	
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TITLE:

Programmable controllers - Part 9: Single-drop digital communication interface for small sensors and actuators (SDCI)

PROPOSED STABILITY DATE: 2025

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Title:
Programmable controllers — Part 9: Single-drop digital communication interface for small sensors and actuators (SDCI)

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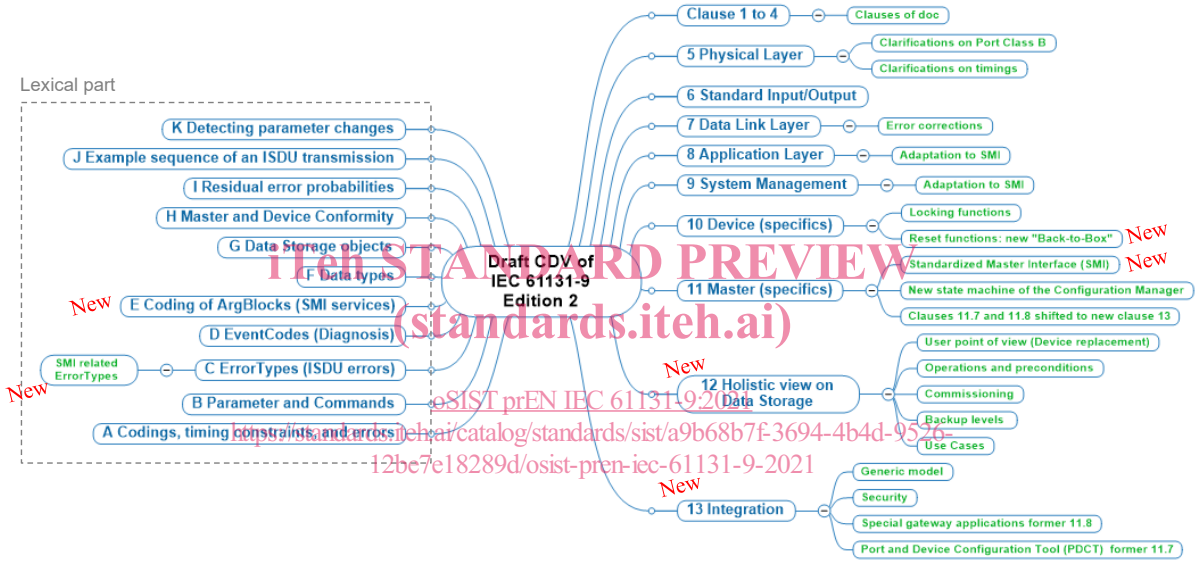

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